

**Search Notes**

Application/Control No.

09/845,454

Examiner

Binh X. Tran

Applicant(s)/Patent under  
Reexamination

RANGARAJAN ET AL.

Art Unit

1765

**SEARCHED**

Class	Subclass	Date	Examiner
156	345.13	12/15/2005	BT
156	345.15	12/15/2005	BT
156	345.22	12/15/2005	BT
156	345.24	12/15/2005	BT
156	345.35	12/15/2005	BT

**INTERFERENCE SEARCHED**

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156	345.13	12/15/2005	BT
156	345.15	12/15/2005	BT
156	345.22	12/15/2005	BT
156/345.24 156/345.35		12/15/2005	BT

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Update search using USPAT, USPG-PUB, JPO, EPO, DERWENT database	12/15/2005	BT